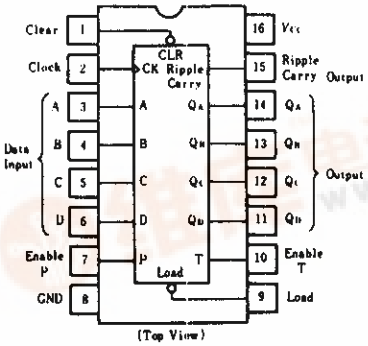
HD74LS162A

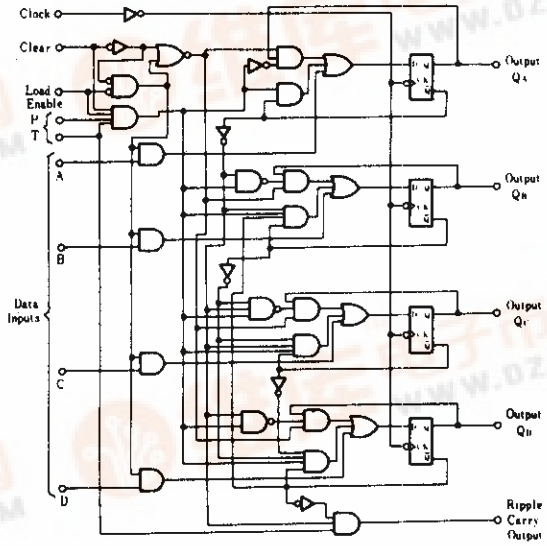
● Synchronous Decade Counters (synchronous clear)

This synchronous decade counter features an internal carry look-ahead for application in high-speed counting designs. Synchronous operation is provided by having all flip-flops clocked simultaneously so that the outputs change coincident with each other when so instructed by the count-enable inputs and internal gating. This mode of operation eliminates the output counting spikes that are normally associated with asynchronous (ripple clock) counters. A buffered clock input triggers the four flip-flops on the rising (positive-going) edge of the clock input waveform. This counter is fully programmable; that is, the outputs may be preset to either level. As presetting is synchronous, setting up a low level at the load input disables the counter and causes the outputs to agree with the setup data after the next clock pulse regardless of the levels of the enable inputs. Low-to-high transitions at the load input should be avoided when the clock is low if the enable inputs are high at or before the transition. The clear function is synchronous and a low level at the clear input sets all four of the flip-flop outputs low after the next clock pulse, regardless of the levels of the enable inputs. This synchronous clear allows the count length to be modified easily as decoding the maximum count desired can be accomplished with one external NAND gate. The gate output is connected to the clear input to synchronously clear the counter to LLLL. Low-to-high transitions at the clear input should be avoided when the clock is low if the enable and load inputs are high at or before the transition. The carry look-ahead circuitry provides for cascading counters for n-bit synchronous applications without additional gating. Instrumental in accomplishing this function are two count-enable inputs and a ripple carry output. Both count-enable inputs (P and T) must be high to count, and input T is fed forward to enable the ripple carry output. The ripple carry output thus enabled will produce a high-level output pulse with a duration approximately equal to the high-level portion of the Q_A output. This high-level overflow ripple carry pulse can be used to enable successive cascaded stages. High-to-low-level transitions at the enable P or T inputs should occur only when the clock input is high.

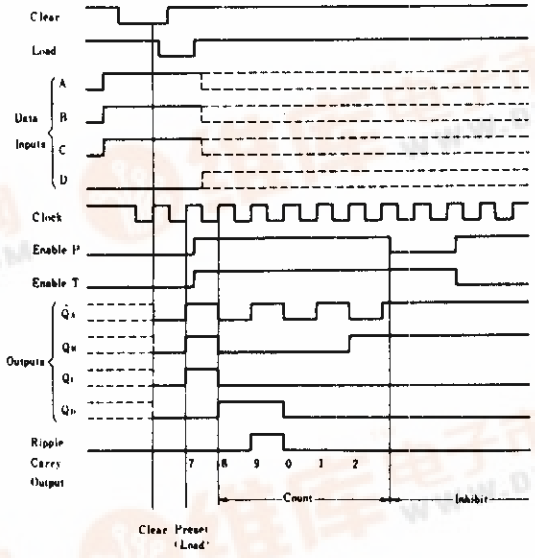
■PIN ARRANGEMENT



■BLOCK DIAGRAM



■TYPICAL CLEAR, PRESET, AND INHIBIT SEQUENCE



■RECOMMENDED OPERATING CONDITIONS

Item		Symbol	min	typ	max	Unit
Clock frequency		f_{clock}	0	—	25	MHz
Clock pulse width		$t_{w(CK)}$	25	—	—	ns
Clear pulse width		$t_{w(CLR)}$	20	—	—	ns
Setup time	A, B, C, D	t_{su}	20	—	—	ns
	Enable P, T		20	—	—	ns
	Load		20	—	—	ns
	Clear		20	—	—	ns
Hold time		t_h	3	—	—	ns

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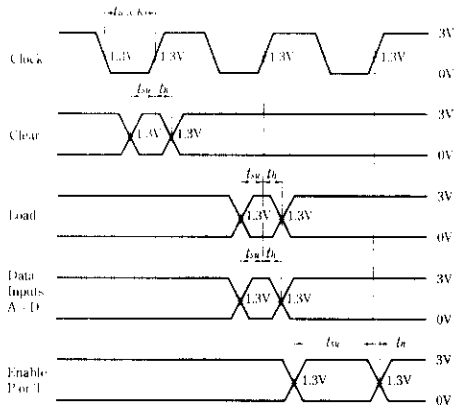
■TIMING DEFINITION



■ELECTRICAL CHARACTERISTICS ($Ta = -20 \sim +75°C$)

Item		Symbol	Test Conditions	min	typ*	max	Unit
Input voltage		V_{IH}		2.0	–	–	V
		V_{IL}		–	–	0.8	V
Output voltage		V_{OH}	V_{CC} = 4.75V, V_{IH} = 2V, V_{IL} = 0.8V, I_{OH} = −400μA	2.7	–	–	V
		V_{OL}	V_{CC} = 4.75V, V_{IH} = 2V, V_{IL} = 0.8V, I_{OL} = 4mA	–	–	0.4	V
			V_{CC} = 4.75V, V_{IH} = 2V, V_{IL} = 0.8V, I_{OL} = 8mA	–	–	0.5	V
Input current	Data, Enable P	I_{IH}	V_{CC} = 5.25V, V_I = 2.7V	–	–	20	μA
	Load, Clock, Enable T			–	–	40	μA
	Clear			–	–	40	μA
	Data, Enable P	I_{IL}	V_{CC} = 5.25V, V_I = 0.4V	–	–	−0.4	mA
	Load, Clock, Enable T			–	–	−0.8	mA
	Clear			–	–	−0.8	mA
	Data, Enable P	I_I	V_{CC} = 5.25V, V_I = 7V	–	–	0.1	mA
	Load, Clock, Enable T			–	–	0.2	mA
	Clear			–	–	0.2	mA
Short-circuit output current		I_{OS}	V_{CC} = 5.25V	−20	–	−100	mA
Supply current**		I_{CCH}	V_{CC} = 5.25V	–	18	31	mA
		I_{CCL}	V_{CC} = 5.25V	–	19	32	mA
Input clamp voltage		V_{IK}	V_{CC} = 4.75V, I_{IN} = −18mA	–	–	−1.5	V

* V_{CC}=5V, Ta=25°C

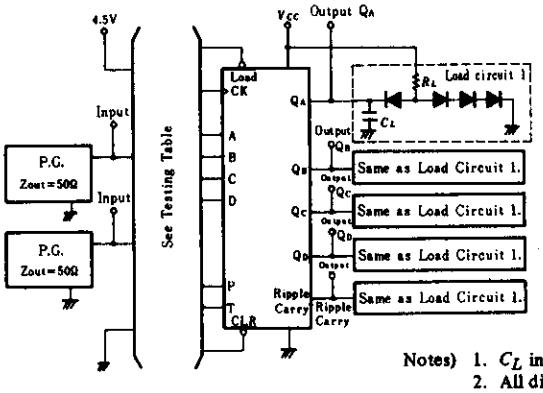
** I_{CCH} is measured with the load input high, then again with the load input low, with all other inputs high and all outputs open. I_{CCL} is measured with the clock input high, then again with the clock input low, with all other inputs low and all outputs open.

■SWITCHING CHARACTERISTICS (V_{CC} = 5V, Ta = 25°C)

Item	Symbol	Inputs	Outputs	Test Conditions	min	typ	max	Unit
Maximum clock frequency	f_{max}	Clock	$Q_A \sim Q_D$	C_L = 15pF, R_L = 2kΩ	25	32		MHz
Propagation delay time	t_{PLH}	Clock	Ripple Carry		–	20	35	ns
	t_{PHL}				–	18	35	ns
	t_{PLH}	Clock (Load="H")	$Q_A \sim Q_D$		–	13	24	ns
	t_{PHL}				–	18	27	ns
	t_{PLH}	Clock (Load="L")	$Q_A \sim Q_D$		–	13	24	ns
	t_{PHL}				–	18	27	ns
	t_{PLH}	Enable T	Ripple Carry		–	9	14	ns
	t_{PHL}				–	9	14	ns
	t_{PHL}	Clear	$Q_A \sim Q_D$		–	20	28	ns

■TESTING METHOD

1) Test Circuit



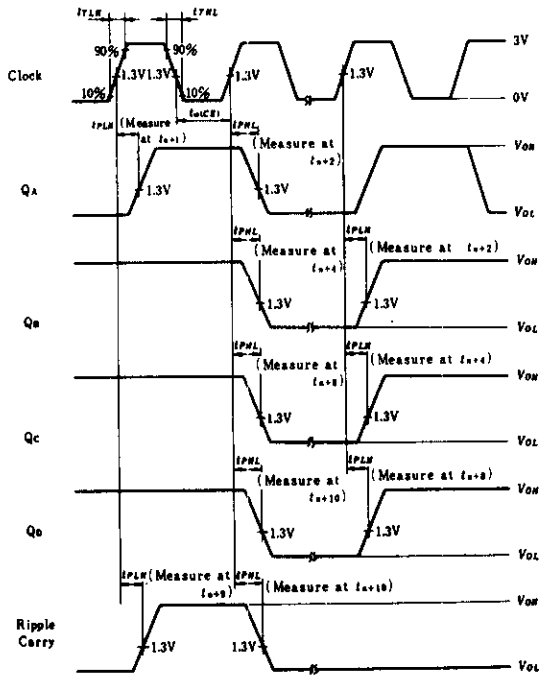
Notes) 1. C_L includes probe and jig capacitance.
2. All diodes are 1S2074 Ⓗ

2) Testing Table

Item	From input to output	Inputs									Outputs				
		Clear	Load	Enable P	Enable T	Clock	Data A	Data B	Data C	Data D	Q_A	Q_B	Q_C	Q_D	Ripple Carry
f_{max}		4.5V	4.5V	4.5V	4.5V	IN	GND	GND	GND	GND	OUT	OUT	OUT	OUT	OUT
t_{PLH} t_{PHL}	CK→Ripple Carry	4.5V	4.5V	4.5V	4.5V	IN	GND	GND	GND	GND	–	–	–	–	OUT
	CK→Q	4.5V	4.5V	4.5V	4.5V	IN	GND	GND	GND	GND	OUT	OUT	OUT	OUT	–
	CK→Q	4.5V	GND	GND	GND	IN	IN*	IN*	IN*	IN*	OUT	OUT	OUT	OUT	–
	Enable T→Ripple Carry	4.5V	GND	4.5V	IN	IN**	4.5V	GND	GND	4.5V	–	–	–	–	OUT
	Clear→Q	IN	GND	GND	GND	IN**	4.5V	4.5V	4.5V	4.5V	OUT	OUT	OUT	OUT	–

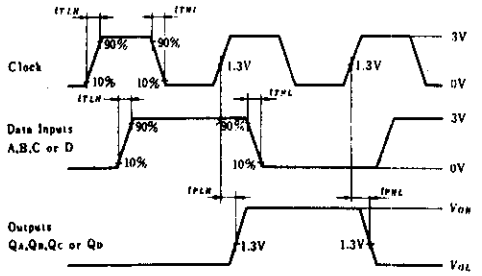
* Measuring outputs correspond to this condition, each outputs (Q_A, Q_B, Q_C, and Q_D) must not be over the following rate, "H", "L", "L", and 'H".
** For initialized

3) Waveform−1 f_{max}, t_{PLH}, t_{PHL} (Clock→Q, Ripple Carry)



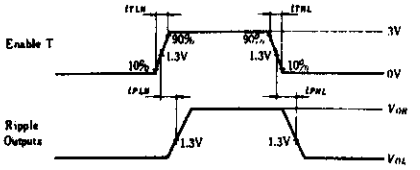
Notes) 1. Clock input pulse; $t_{TLH} \leqq 15$ns, $t_{THL} \leqq 6$ns, PRR=1MHz, duty cycle=50% and: for f_{max}, $t_{TLH} = t_{THL} \leqq 2.5$ns.
2. t_n is reference bit time when all outputs are low.

Waveform−2 t_{PLH}, t_{PHL} (Clock→Q)



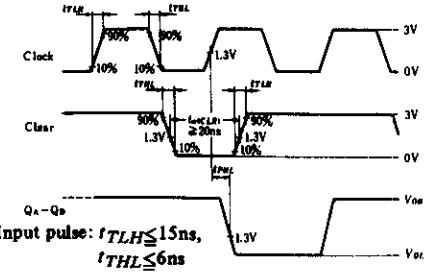
Notes) Input pulse: $t_{TLH} \leqq 15$ns, $t_{THL} \leqq 6$ns, Clock input: PRR= 1MHz, duty cycle 50%, Data input: PRR=500kHz, duty cycle 50%

Waveform−3 t_{PLH}, t_{PHL} (Enable T→Ripple Carry)



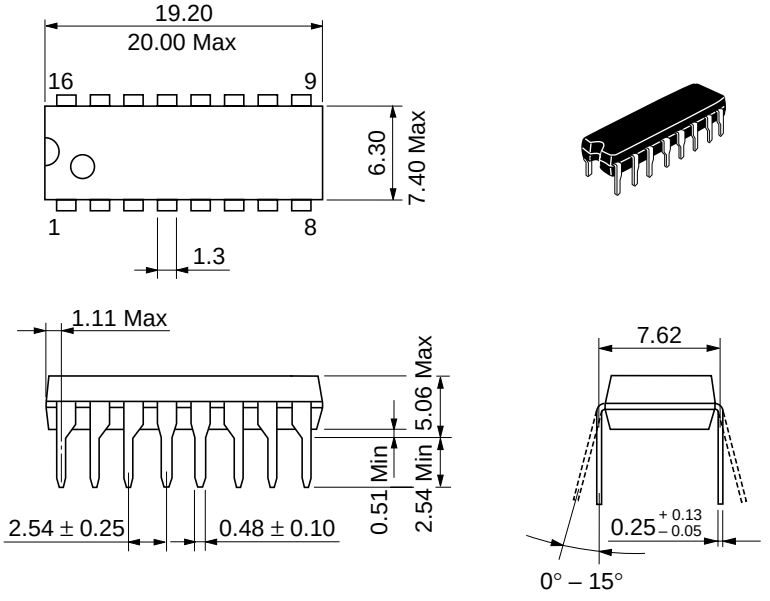
Note) Input pulse: $t_{TLH} \leqq 15$ns, $t_{THL} \leqq 6$ns, PRR=1MHz

Waveform−4 t_{PHL} (Clear→Q)

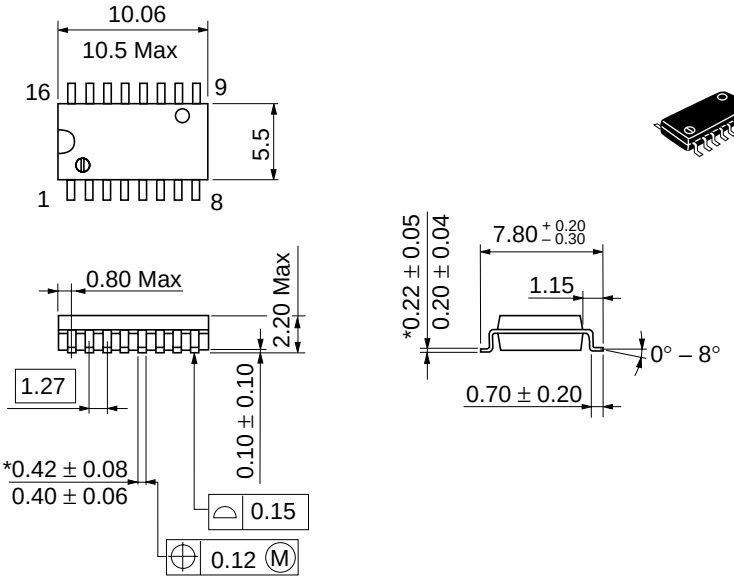


Note) Input pulse: $t_{TLH} \leqq 15$ns, $t_{THL} \leqq 6$ns

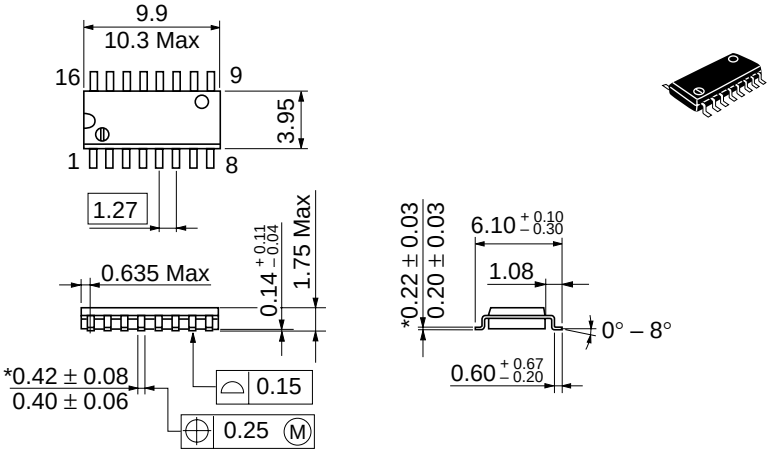
Unit: mm


19.20
20.00 Max
16
9
6.30
7.40 Max
1
8
1.3
1.11 Max
5.06 Max
0.51 Min
2.54 Min
2.54 ± 0.25
0.48 ± 0.10
7.62
0.25 + 0.13 − 0.05
0° – 15°

Unit: mm


10.06
10.5 Max
16
9
1
8
5.5
0.80 Max
2.20 Max
1.27
*0.42 ± 0.08
0.40 ± 0.06
0.10 ± 0.10
0.15
0.12 M
*0.22 ± 0.05
0.20 ± 0.04
7.80 +0.20 −0.30
1.15
0° – 8°
0.70 ± 0.20

Unit: mm


9.9
10.3 Max
16
9
1
8
3.95
1.27
0.635 Max
0.14 +0.11 −0.04
1.75 Max
*0.42 ± 0.08
0.40 ± 0.06
0.15
0.25 M
*0.22 ± 0.03
0.20 ± 0.03
6.10 +0.10 −0.30
1.08
0° – 8°
0.60 +0.67 −0.20

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